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Fundamental processes in III-V
photocathodes; application for
high-brightness photoinjectors

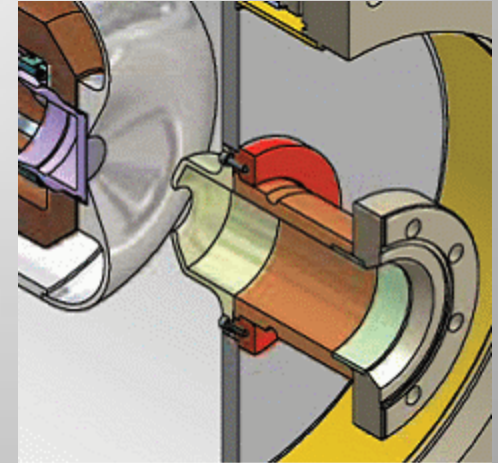


- Motivation
- NEA photoemission
- Some practical aspects
- Study cases: GaAs, GaAsP, GaN
- Summary



Why are we interested?

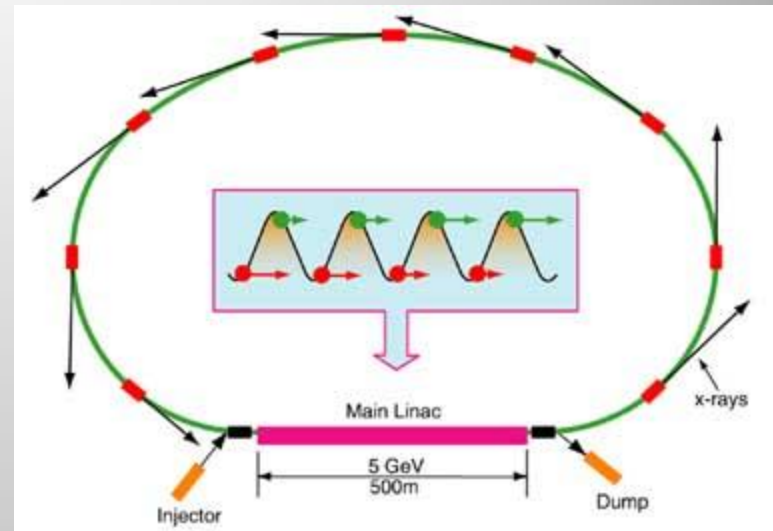
- Photoinjectors: a photocathode in high electric field (\gg MV/m), either DC or RF
- Relativistic electrons can be further accelerated in a linac (linear accelerator) without degradation of beam brightness:
 - CW ultra-bright x-ray sources; high power FELs
 - Electron-ion colliders and ion coolers
 - Ultrafast electron diffraction, etc.





Energy recovery linac

- *Energy recovery linac*: a new class of accelerators in active development
- Essentially removes the average current limitation typical to linacs (i.e. $P_{\text{beam}} \gg P_{\text{wall plug}}$)
- Average currents 10's to 100's of mA can be efficiently accelerated (and de-accelerated)





- QE and photon excitation wavelength

$$i(\text{mA}) = \frac{\lambda(\text{nm})}{124} \times P(\text{W}) \times \text{QE}(\%)$$

- E.g. 1W of
 - 775 nm (Er-fiber $\lambda/2$) \Rightarrow 6.2 mA/%
 - 520 nm (Yb-fiber $\lambda/2$) \Rightarrow 4.2 mA/%
 - 266 nm (Nd-glass $\lambda/4$) \Rightarrow 2.1 mA/%

- Transversely cold (thermalized) electron distribution

- Directly sets the solid angle of the emitted electrons; an upper limit on achievable beam brightness

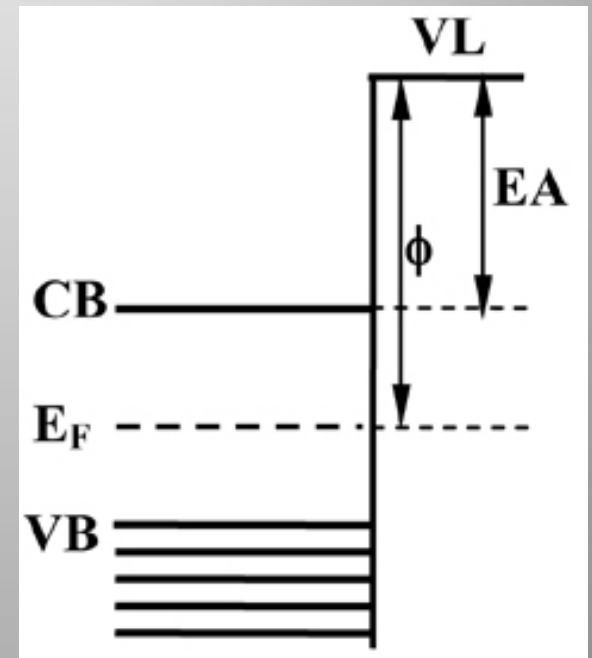


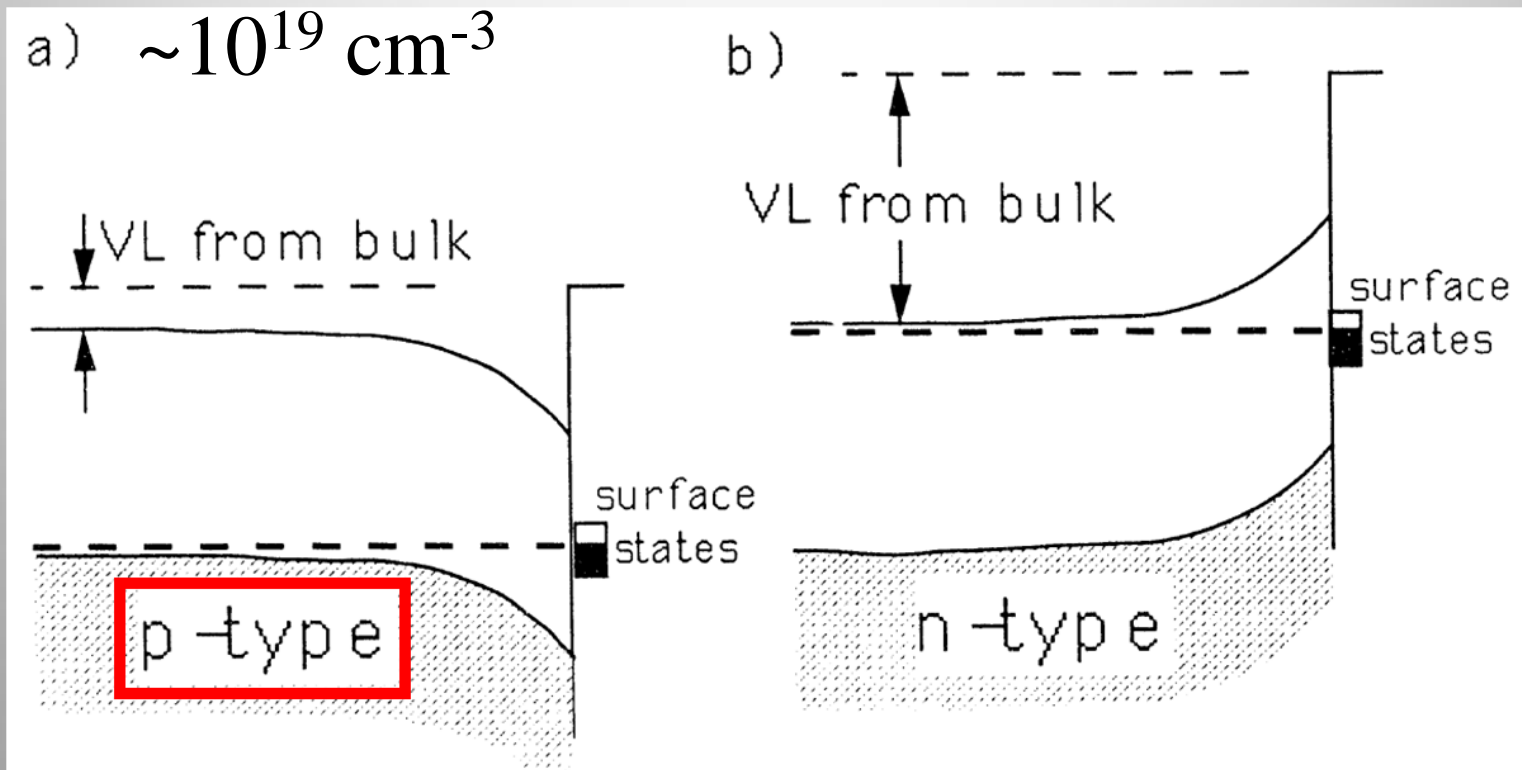
- **Prompt response time**
 - A picosecond response is essential to take advantage of the space charge control via laser pulse shaping
- **Long lifetime and robustness**
 - Extraction of many 100's to 1000's of C between activations are necessary to make the accelerator practical



Negative electron affinity

- Defined as vacuum level E_{vac} relative to the conduction band minimum
- Negative affinity: the vacuum level lies below the CBM \Rightarrow very high QE possible
- NEA:
 - 1) band bending
 - 2) dipole layer



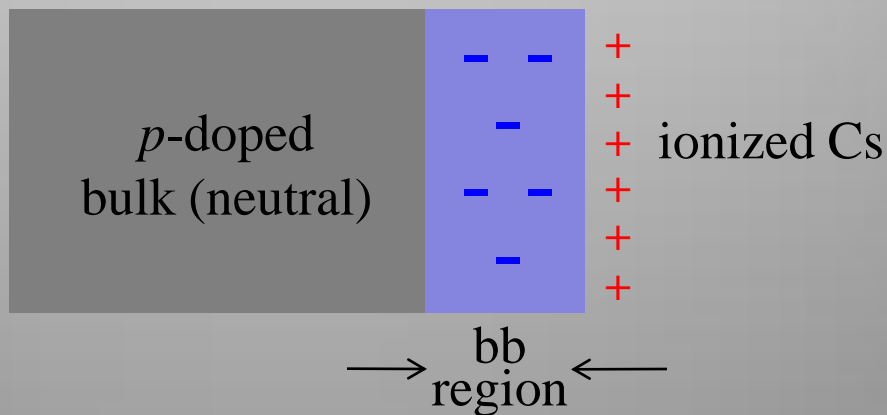


- Alperovich et al., Phys. Rev. B **50** (1994) 5480: clean p-doped GaAs has Fermi level unpinned and shows little band bending



NEA: Cs ~monolayer

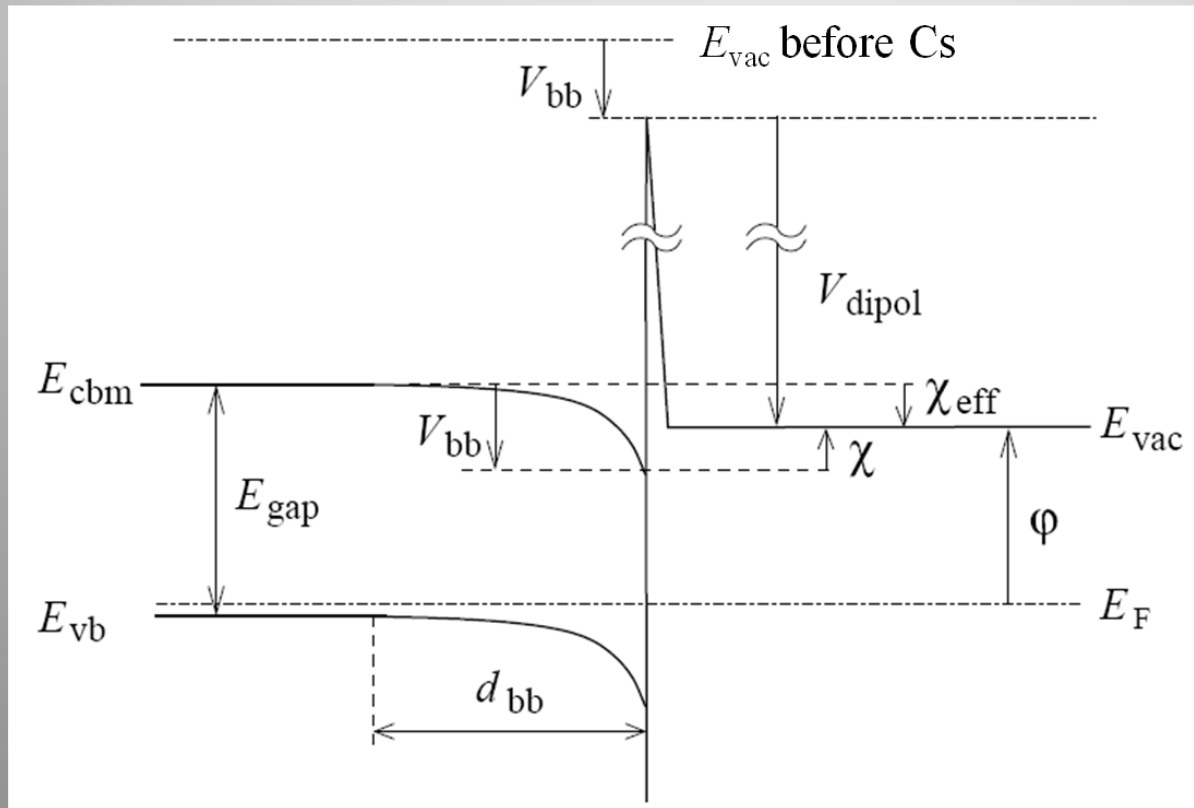
- Cs was found to play a larger role for NEA instead:
 - 1) band bending through donor surface states, and
 - 2) dipole surface layer from polarized Cs adatoms
 - Cs-induced donor-like surface states contribute their electrons to the bulk
 - Hole depleted region (negatively charged acceptors) lead to band bending region





NEA: ~Cs monolayer (contd.)

- Majority of Cs atoms become only polarized (not ionized), forming a dipole layer (e- Cs+)



GaAs

$E_{gap} = 1.42 \text{ eV}$

Before Cs

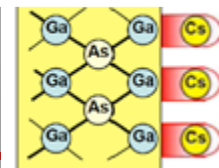
$\chi = 4 \text{ eV}$

After Cs

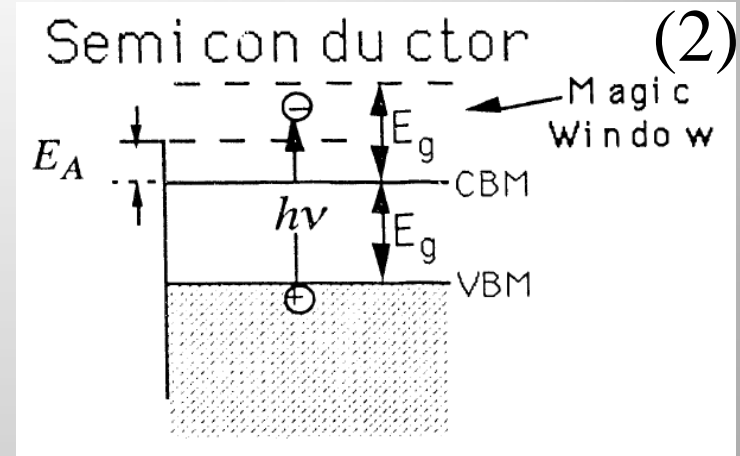
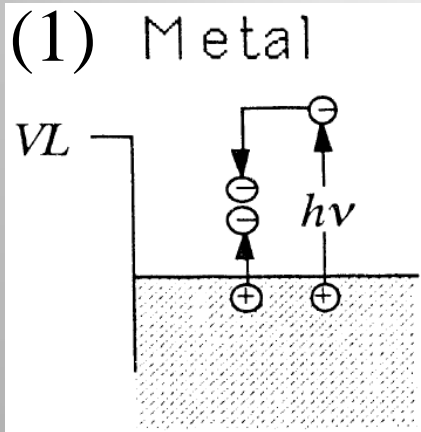
$\chi_{eff} \sim -0.1 \text{ eV}$

$V_{bb} \sim 0.4 \text{ eV}$

$d_{bb} \sim 10 \text{ nm}$

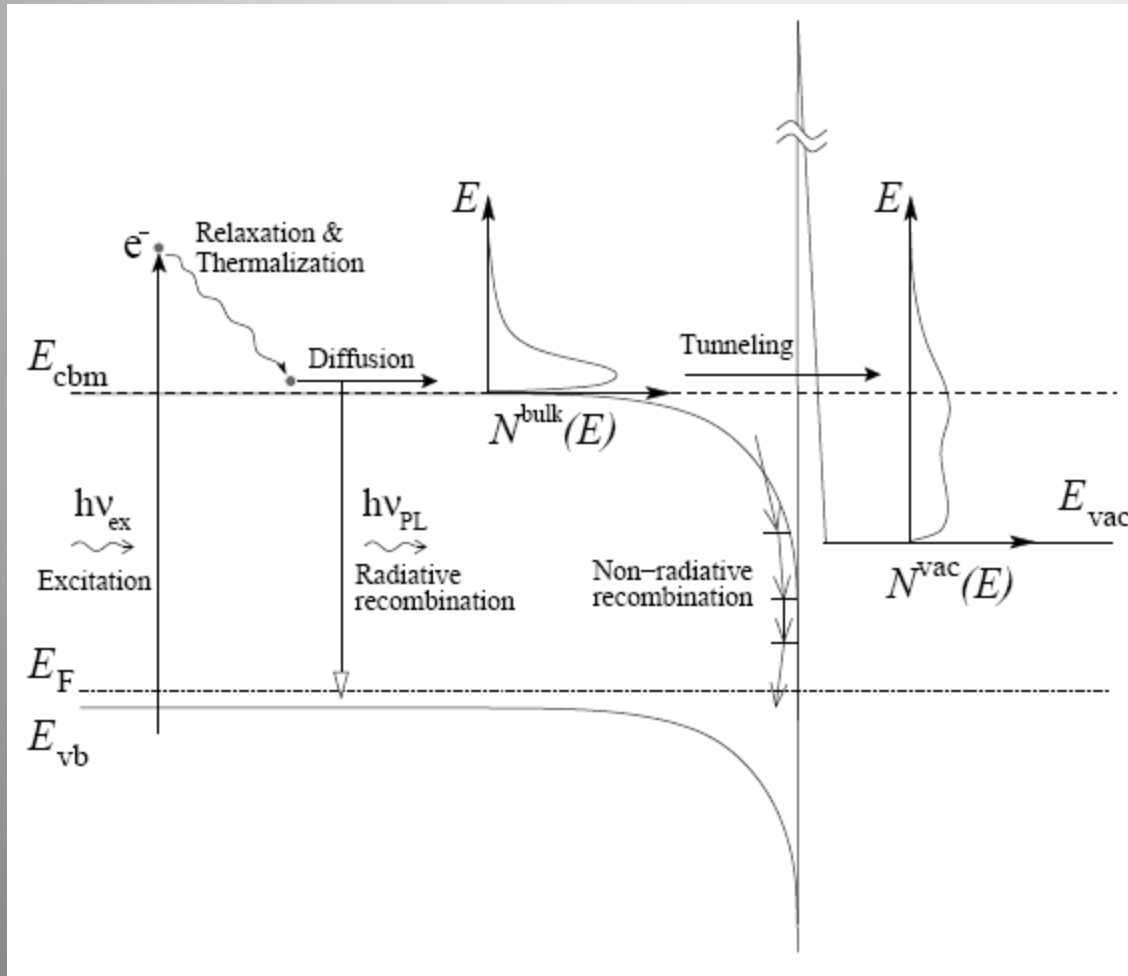


Spicer's magic window



- (1) *electron-electron* scattering: typical of metals, large energy loss per collision
- (2) *electron-phonon* scattering: slowly depletes excessive energy of excited electron (LO phonons in GaAs ~ 35 meV)
- “*Magic window*”: in semiconductors, one needs excess $KE > E_{\text{gap}}$ for e^-/e^- scattering. Thus, electrons excited with $E_{\text{vac}} < KE < E_{\text{VBM}} + 2E_{\text{gap}}$ have excellent chances of escape

Electron transport processes



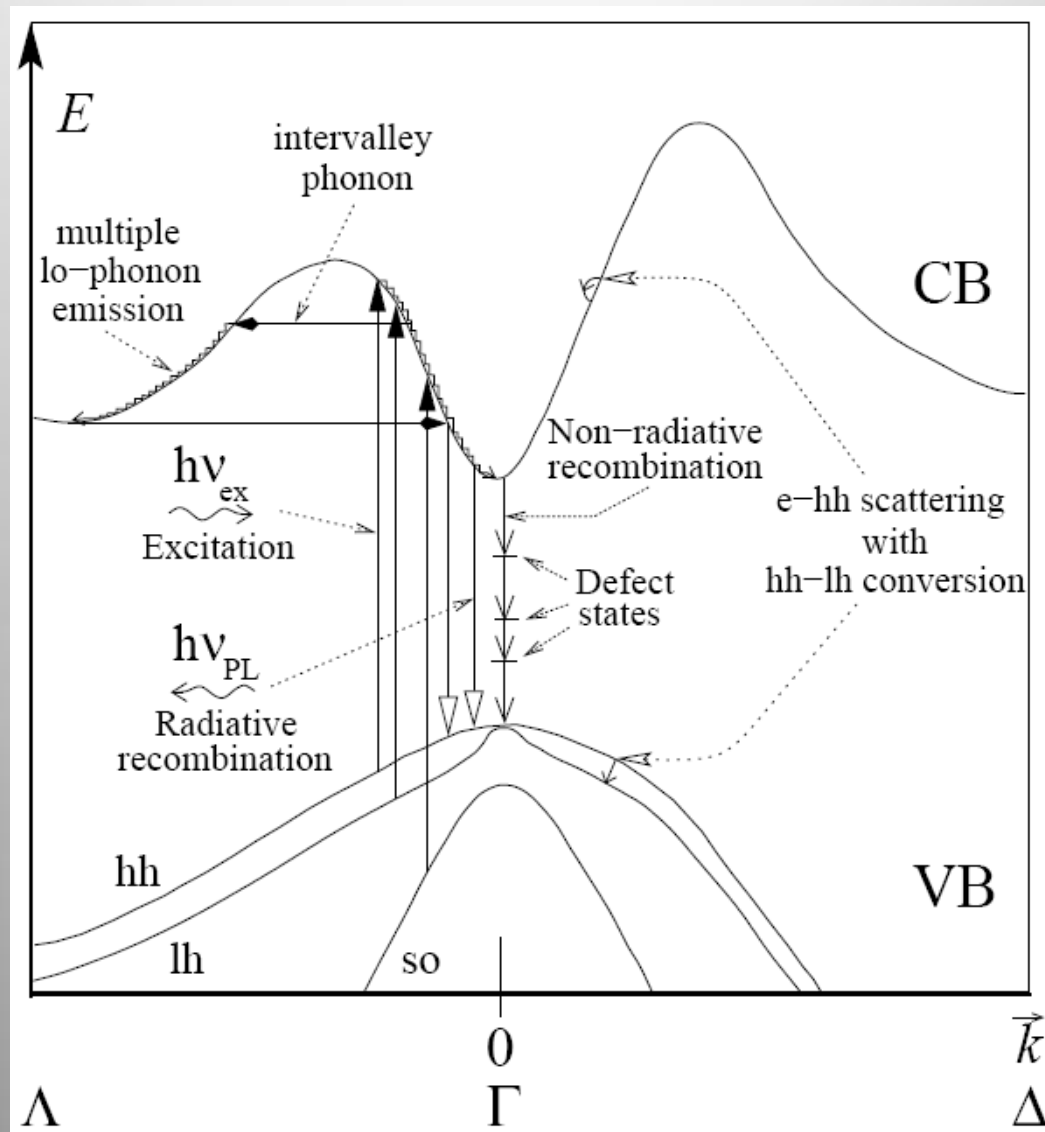
CBM thermalization
time: 0.1-1ps

Electron-hole
recombination: ~ns

Emission time:
 $\propto 1/(\alpha^2 D)$

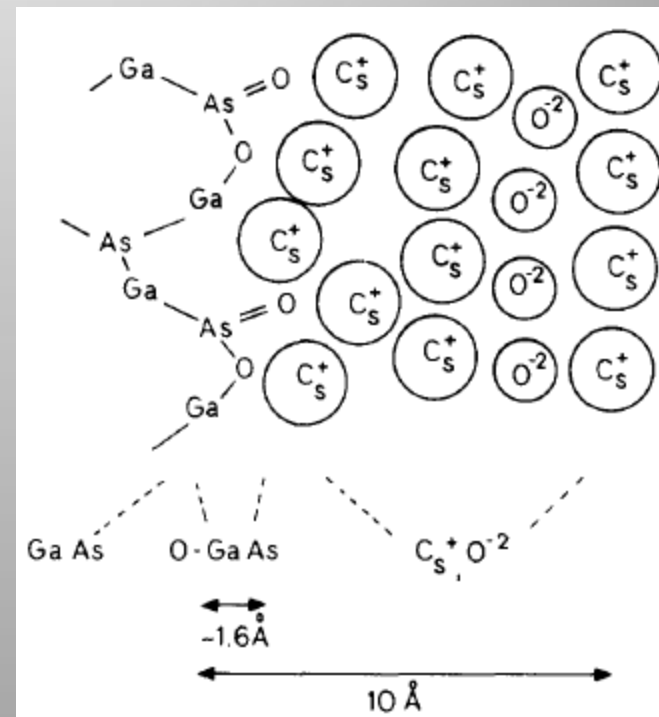
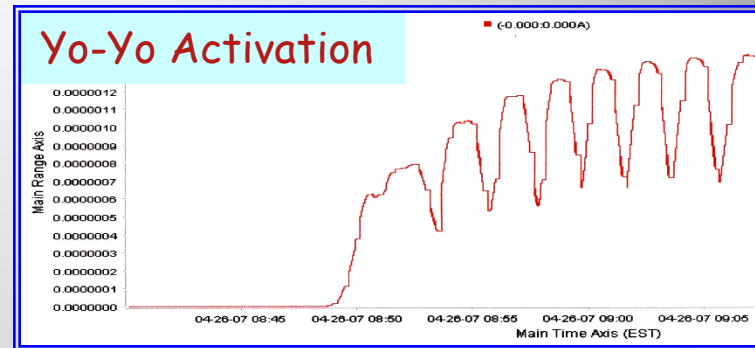
strong wavelength
dependence

Energy vs. momentum



Role of fluorine/oxygen

- Routine “yo-yo” activation employs O_2 or NF_3
- Further reduction of affinity consistent with a double dipole model
- Stabilizes Cs on the surface; no lifetime or otherwise apparent advantage for either gas
- Bonded unstable nitrogen is found on Cs- NF_3 activated surfaces (APL 92, 241107)

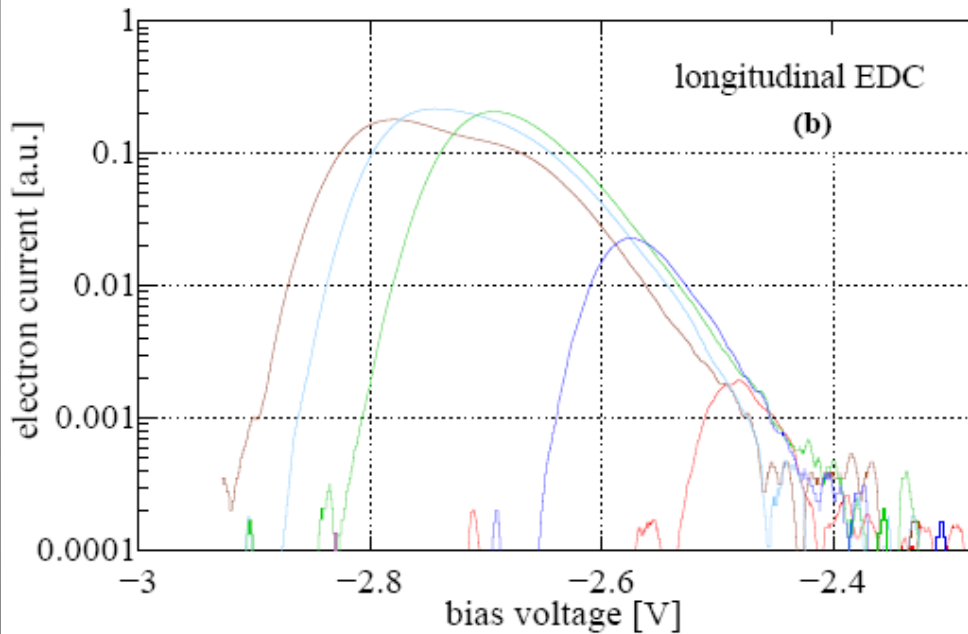
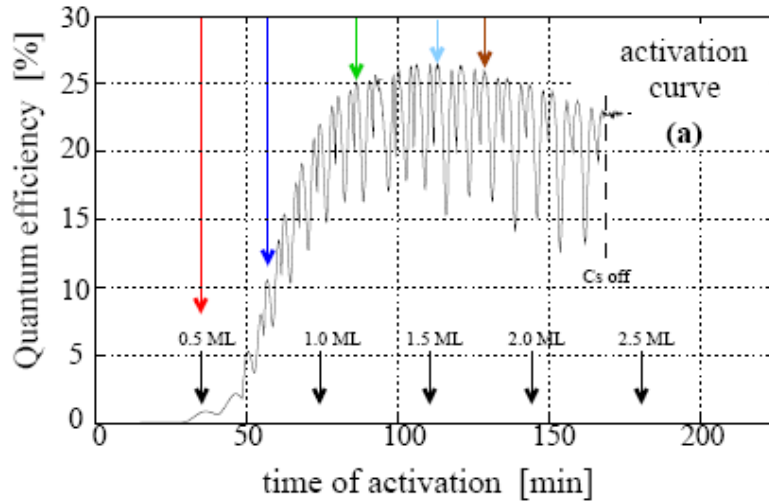


JAP 54 (1983) 1413



GaAs: Optimal Cs coverage

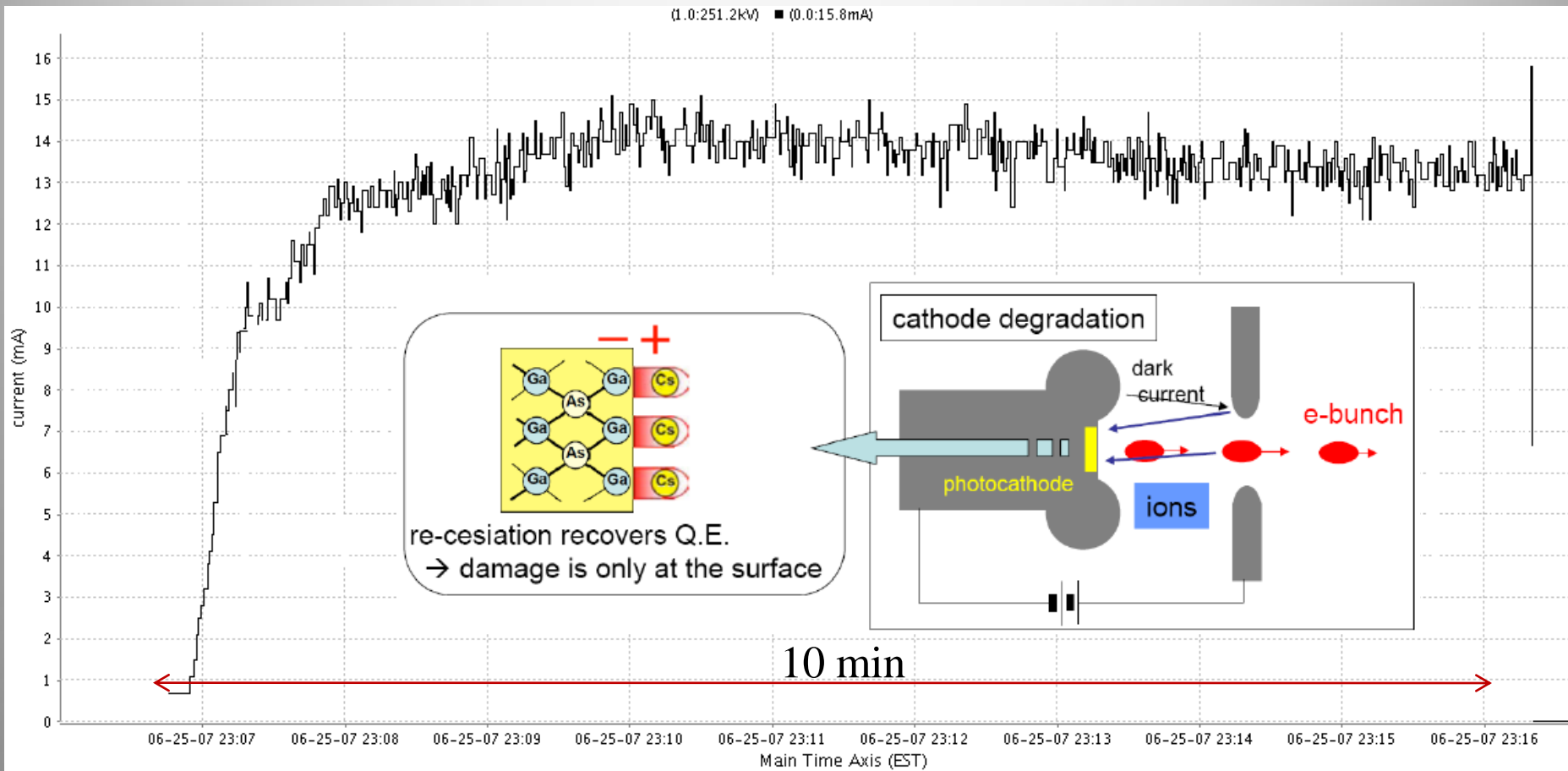
laser wavelength: 670 nm



Ugo Weigel, PhD thesis



- H_2O , CO_2 and O_2 can lead to chemical poisoning of the activated layer
- Low current ($\sim 1\mu\text{A}$) $1/e$ lifetimes ~ 100 hours typical in our prep chambers
- 3-5 times better in the DC gun (low 10^{-12} Torr vacuum)
- High average current (mA's) lifetime limited by ion backbombardment



- ~5 hour lifetime (limited by gas backstreaming from the beam dump), i.e. 20 hours 1/e for 5 mA



- Our group has been evaluating III-V photocathodes
 - Transverse energy of electrons (thermal emittance)
 - Measure the photoemission response time
- Materials studied so far
 - GaAs @ 450-850nm: JAP 103, 054901; PRST-AB 11, 040702
 - GaAsP @ 450-640nm: Ibid
 - GaN @ 260nm: JAP 105, 083715



$$\frac{\partial c(h, t)}{\partial t} = D \frac{\partial^2 c(h, t)}{\partial h^2}$$

subject to:

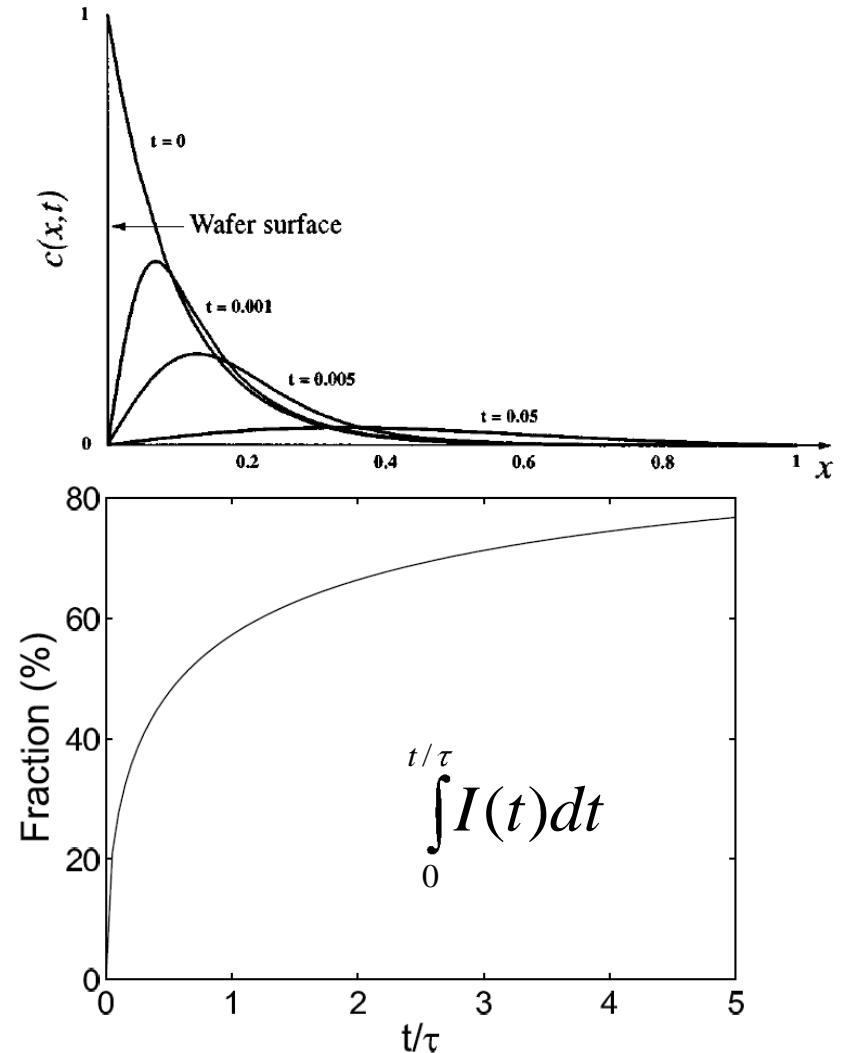
$$c(h, t = 0) = c_0 e^{-\alpha h}$$

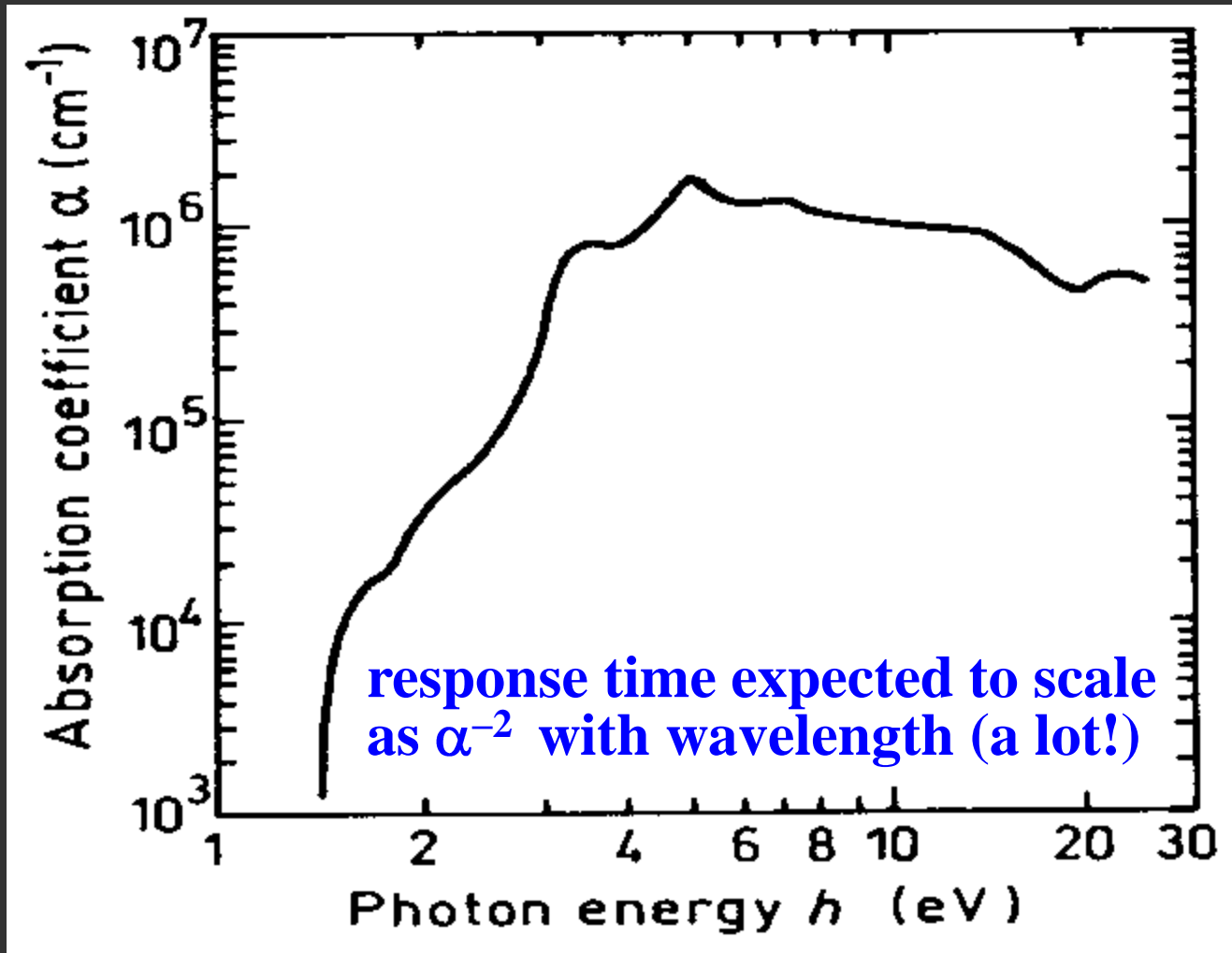
$$c(h = 0, t) = 0$$

$$I(t) \propto \frac{\partial}{\partial t} \int_0^{\infty} c(h, t) dh.$$

$$I(\kappa) \propto \frac{1}{\sqrt{\pi \kappa}} - \exp(\kappa) \operatorname{erfc}(\sqrt{\kappa})$$

$$\kappa \equiv t/\tau, \text{ where } \tau \equiv \alpha^{-2} D^{-1}$$

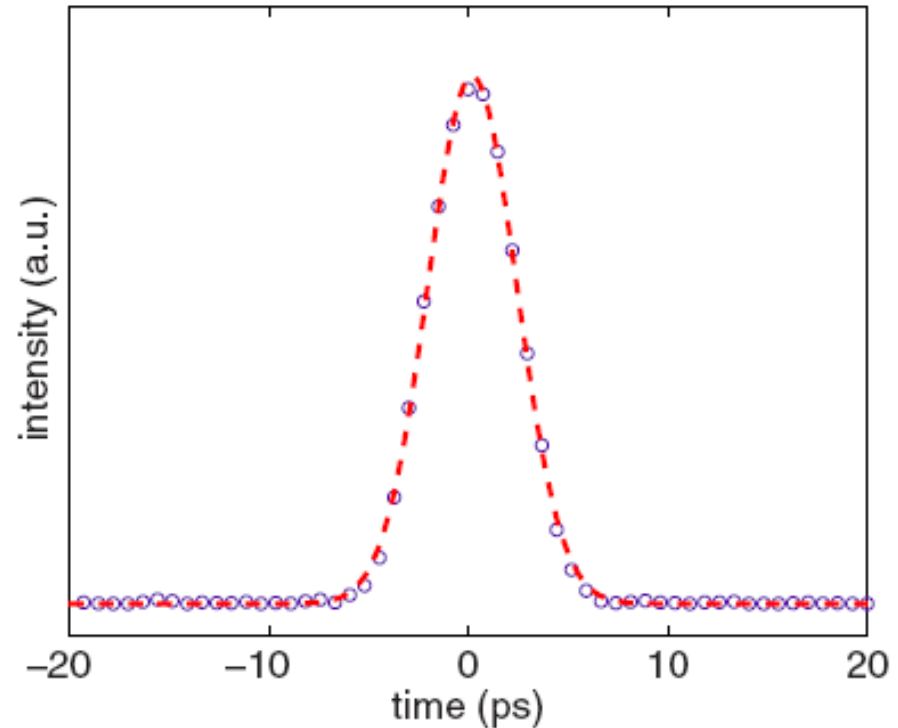
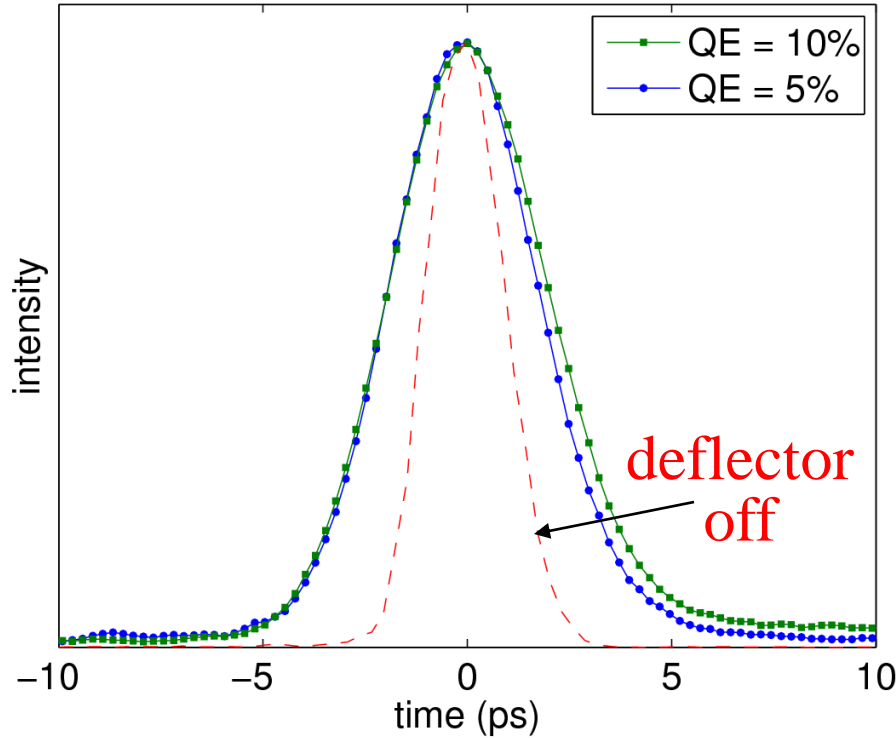






GaAs @ 520 nm

GaN @ 260 nm

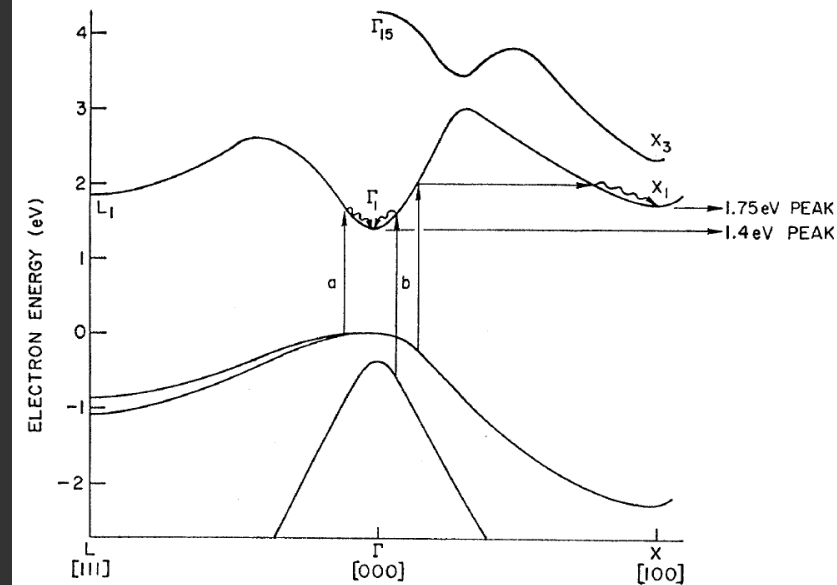
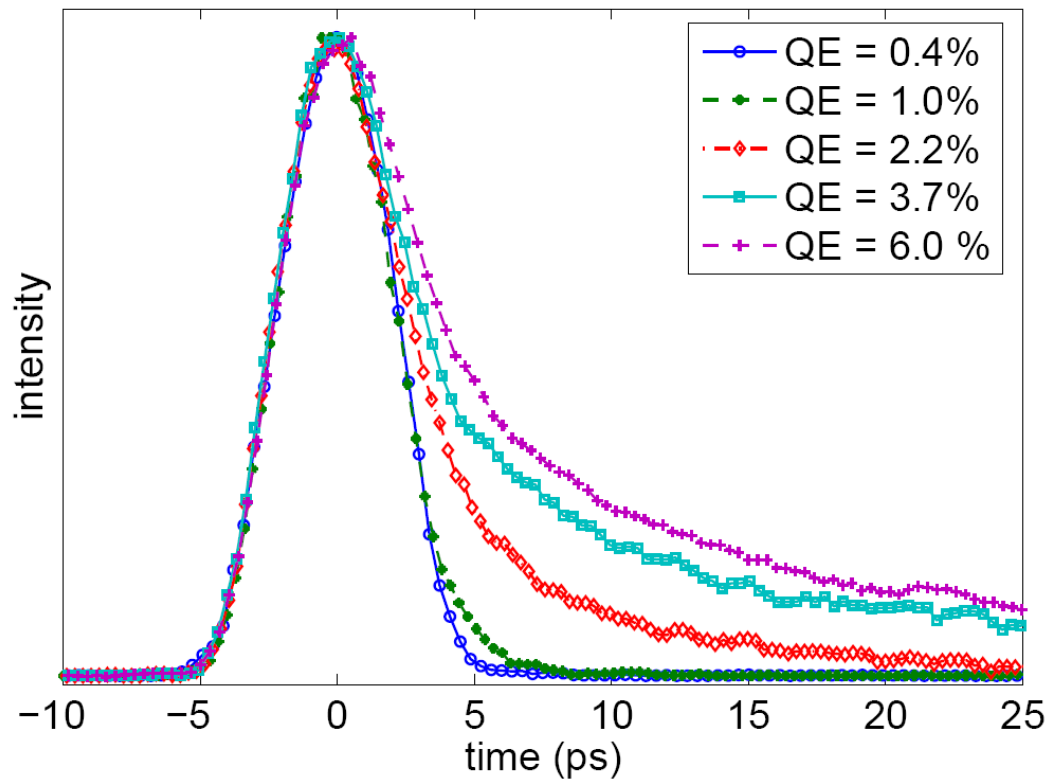


Measurements done by transverse deflecting RF cavity
Limited by 1.8 ps rms resolution dominated by laser to RF synchronization



GaAsP @ 520 nm

P concentration 45%

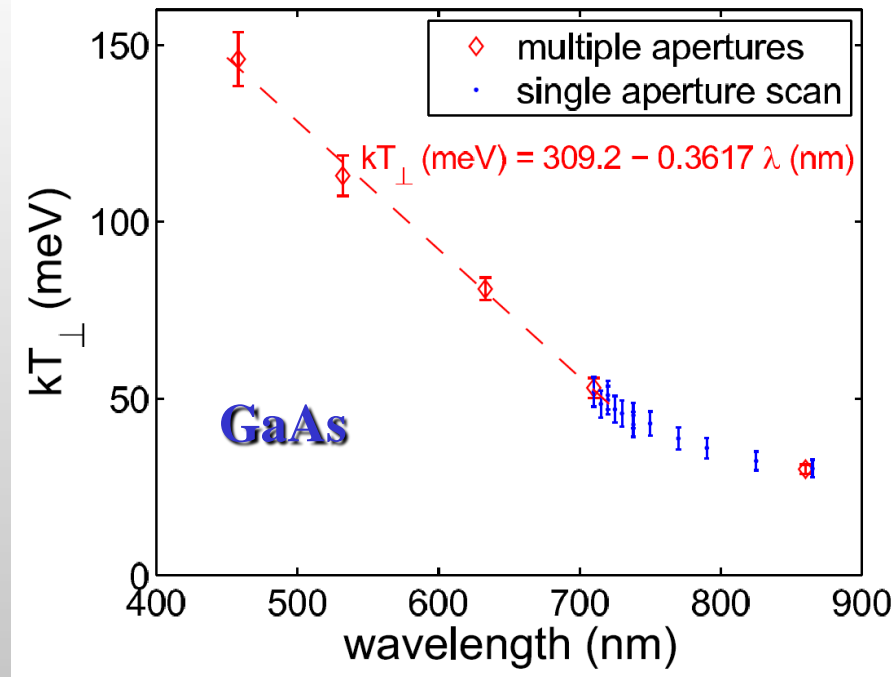


Strong QE dependency

Two valleys: Γ (direct) and X (indirect) involved in the process

Transverse energy distributions

- No surprises for bulk GaAs: cold electrons with a near band-gap excitation
- Surprisingly large transverse energy spread for GaN and GaAsP:



- GaAsP: $kT_{\perp} = 130\text{-}240$ meV for photons 0-780 meV photons above the band-gap
- GaN: $kT_{\perp} = 0.9$ eV for photons with 1.4 eV above the band-gap



- Transverse energy of photoelectrons remain poorly understood for III-V semiconductors (other than GaAs)
- More carefully controlled experimental data on transverse energy distributions/time response needed
- Predictive codes and models need to be developed and benchmarked with experiments
- This will allow photocathode engineering with the desired characteristics such as cold electrons with a ps response



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